PTO/SB/08 Equivalent

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Application No. 10/632,481

Filing Date August 1, 2003

First Named Inventor Talieh et al.

Art Unit 3723

Examiner David Thomas

Attorney Docket No. ASMNUT.012C1CP1

(Multiple sheets used when necessary)
SHEET 1 OF 3

Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
BRT	1	669,923	03-1901	Grauert	
	2	3,888,050	06-1975	Elm	
	3	4,412,400	11-1983	Hammond	
	4	4,802,309	02-1989	Heynacher	
	5	5,245,796	09-1993	Miller et al.	
	6	5,335,453	08-1994	Baldy et al.	
	7	5,377,452	01-1995	Yamaguchi	
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	9	5,429,733	07-1995	Ishida	
	10	5,489,235	02-1996	Gagliardi et al.	
	11	5,558,568	09-1996	Talieh et al.	
	12	5,650,039	07-1997	Talieh	
	13	5,679,212	10-1997	Kato et al.	
	14	6,692,947	12-1997	Talieh et al.	
	15	5,707,409	01-1998	Martin et al.	·
	16	5,759,918	06-1998	Hoshizaki et al.	·
	17	5,762,751	06-1998	Bleck et al.	
	18	5,770,521	06-1998	Pollock	
1.	19	5,807,165	09-1998	Uzoh et al.	
	20	5,810,964	09-1998	Shiraishi	
•	21	5,851,136	12-1998	Lee	
1	22	5,893,755	04-1999	Nakayoshi	
	23	5,899,798	05-1999	Trojan et al.	
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Examiner Signature	Date Considered	4/27/05	
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^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T¹ - Place a check mark in this area when an English language Translation is attached.

PTO/SB/08 Equivalent

STATEMENT BY APPLICANT

(Multiple sheets used when necessary)
SHEET 2 OF 3

		F 10/38/00 Equivalent
Application No.	10/632,481	
Filing Date	August 1, 2003	
First Named Inventor	Talieh et al.	
Art Unit	3723	•
Examiner	David Thomas	
Attorney Docket No.	ASMNUT.012C1CP1	

			U.S. PATENT	DOCUMENTS	
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
13.7	30	5,975,988	11-1999	Christianson	
	31	6,017,831	01-2000	Beardsley et al.	
	32	6,068,542	05-2000	Hosokai	
	33	6,110,025	08-2000	Williams et al.	
	34	6,113,479	09-2000	Sinclair et al.	
	35	6,129,540	10-2000	Hoopman et al.	·
	36	6,135,859	10-2000	Tietz	
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Examiner Signature	Date Considered	4/21/05

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SHEET 3 OF 3

Application No. 10/632,481

Filing Date August 1, 2003

First Named Inventor Talieh et al.

Art Unit 3723

Examiner David Thomas

Attomey Docket No. ASMNUT.012C1CP1

Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
187	56	DE 3113204	10-1982	Lambelet		
	57	EP 0 517 594	12-1992	Baldy		
	58	EP 0 941 806 A2	09-1999	Jew et al.	,	
	59	EP 1 025 955 A2	08-2000	Somekh et al.		
	60	WO 97/20660	06-1997	Shendon		
	61	WO 98/45090	10-1998	Donhue et al.		
	62	WO 99/22908	05-1999	Sommer		
	63	WO 00/32356	06-2000	Talieh		
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	NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T¹		
ds 7	65	STEIGERWALD et al., "Pattern geometry effects in the chemical-mechanical polishing of inlaid copper structures," October 1994, pp. 2842-2848.			

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4/27/15

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